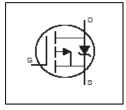
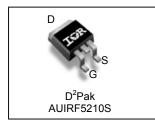


Features

- Advanced Process Technology
- P-Channel MOSFET
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- Fast Switching
- Fully Avalanche Rated
- · Repetitive Avalanche Allowed up to Timax
- · Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{DSS}		-100V
R _{DS(on)}	max.	60mΩ
I _D		-38A



G	D	S
Gate	Drain	Source

Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications..

Base part number Dealeage Type		Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
ALUDES240C	D ² -Pak	Tube	50	AUIRF5210S
AUIRF5210S D ² -Pak		Tape and Reel Left	800	AUIRF5210STRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Symbol Parameter		Units	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10V	-38		
D @ T _C = 100°C Continuous Drain Current, V _{GS} @ -10V		-24	Α	
I _{DM}	Pulsed Drain Current ①	-140		
P _D @T _A = 25°C	Maximum Power Dissipation	3.1	107	
P _D @T _C = 25°C	Maximum Power Dissipation	170	W	
Linear Derating Factor		1.3	W/°C	
V _{GS} Gate-to-Source Voltage		± 20	V	
E _{AS} Single Pulse Avalanche Energy (Thermally Limited) ②		120	mJ	
I _{AR} Avalanche Current ①		-23	Α	
E _{AR} Repetitive Avalanche Energy ①		17	mJ	
dv/dt Peak Diode Recovery dv./dt ③		-7.4	V/ns	
TJ	Operating Junction and	-55 to + 150		
T _{STG}	Storage Temperature Range		°C	
	Soldering Temperature, for 10 seconds (1.6mm from case)	300		

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case ©		0.75	°C // //
$R_{ hetaJA}$	Junction-to-Ambient (PCB Mount, steady state) ©		40	°C/W

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2015-9-30

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-100			V	$V_{GS} = 0V, I_{D} = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.11		V/°C	Reference to 25°C, I _D = -1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			60	mΩ	$V_{GS} = -10V, I_D = -38A \oplus$
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	٧	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
gfs	Forward Trans conductance	9.5			S	$V_{DS} = -50V, I_{D} = -23A$
ı	Drain-to-Source Leakage Current			-50	μA	$V_{DS} = -100V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			-250	μΑ	$V_{DS} = -80V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			-100	- Λ	$V_{GS} = -20V$
I _{GSS}	Gate-to-Source Reverse Leakage			100	nA	$V_{GS} = 20V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q_{α}	Total Gate Charge	 150	230		I _D = -23A
Q_{gs}	Gate-to-Source Charge	 22	33	nC	$V_{DS} = -80V$
Q_{gd}	Gate-to-Drain Charge	 81	120		V _{GS} = -10V4
$t_{d(on)}$	Turn-On Delay Time	 14			$V_{DD} = -50V$
tr	Rise Time	 63		no	$I_{D} = -23A$
$t_{d(off)}$	Turn-Off Delay Time	 72		ns	$R_G = 2.4\Omega$
t _f	Fall Time	 55			V _{GS} = -10V ④
L_D	Internal Drain Inductance	 4.5			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance	 7.5			from package and center of die contact
C _{iss}	Input Capacitance	 2780			V _{GS} = 0V
C _{oss}	Output Capacitance	 800		pF	$V_{DS} = -25V$
C_{rss}	Reverse Transfer Capacitance	 430			f = 1.0MHz, See Fig. 5

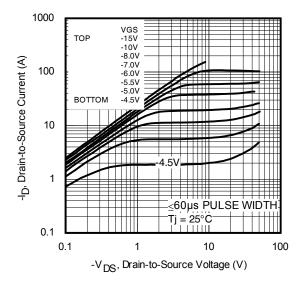
Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			-38		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			-140		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			-1.6	V	$T_J = 25^{\circ}C, I_S = -23A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		170	260	ns	$T_J = 25^{\circ}C$, $I_F = -23A$, $V_{DD} = -25V$
Q_{rr}	Reverse Recovery Charge		1180	1770	nC	di/dt = -100A/µs ④
t_{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- @ Limited by T_{Jmax} , starting T_J = 25°C, L = 0.46mH, R_G = 25 Ω , I_{AS} = -23A.(See Fig.12)
- $\exists \quad I_{SD} \leq \mbox{ -23A, di/dt} \leq \mbox{-650A/}\mu\mbox{s, } V_{DD} \leq V_{(BR)DSS}, \mbox{ } T_J \leq 150\mbox{°C}.$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- S This is applied to D²Pak When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- ® R_θ is measured at T_J of approximately 90°C.





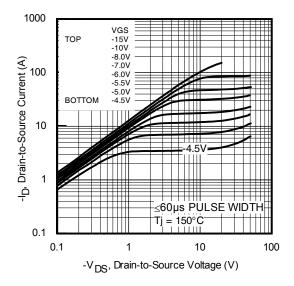


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics

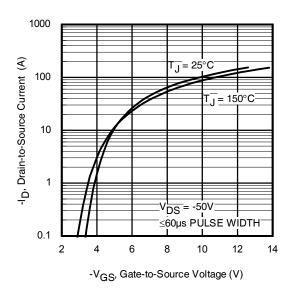


Fig. 3 Typical Transfer Characteristics

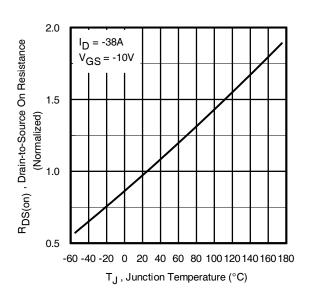


Fig. 4 Normalized On-Resistance vs. Temperature



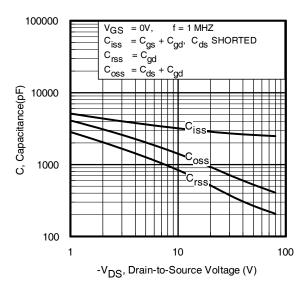


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

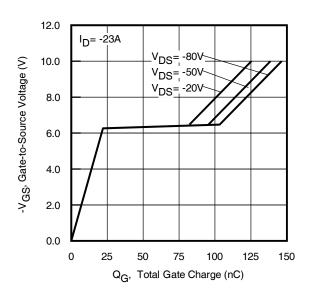


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

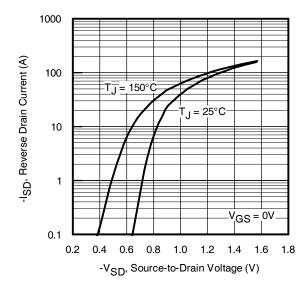


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

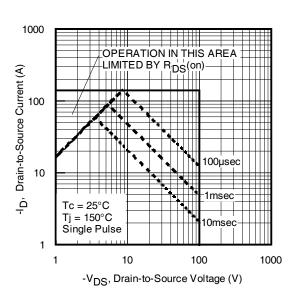


Fig 8. Maximum Safe Operating Area



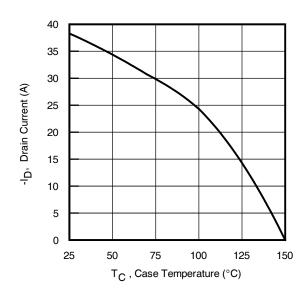


Fig 9. Maximum Drain Current vs. Case Temperature

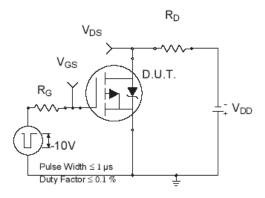


Fig 10a. Switching Time Test Circuit

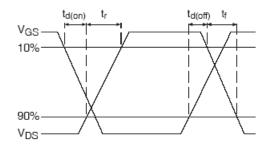


Fig 10b. Switching Time Waveforms

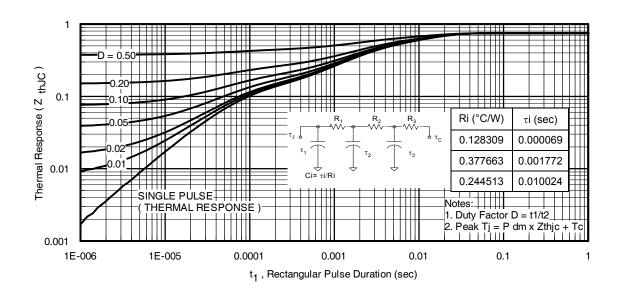


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



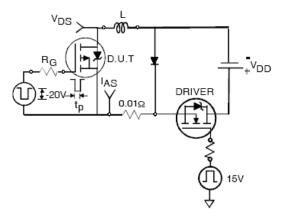


Fig 12a. Unclamped Inductive Test Circuit

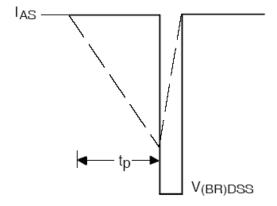


Fig 12b. Unclamped Inductive Waveforms

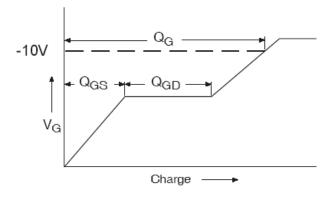


Fig 14a. Gate Charge Waveform

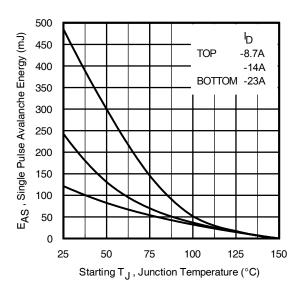


Fig 13. Maximum Avalanche Energy vs. Drain Current

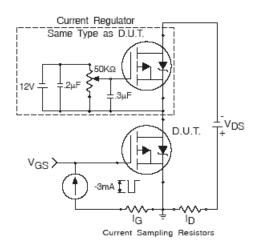
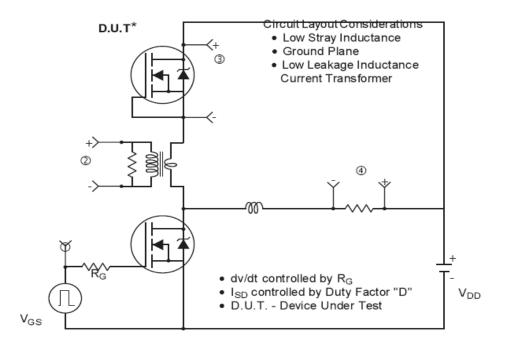
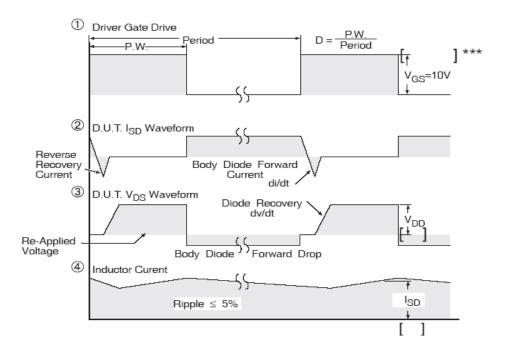


Fig 14b. Gate Charge Test Circuit





^{*} Reverse Polarity of D.U.T for P-Channel

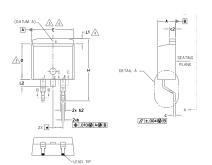


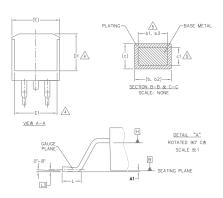
*** V_{GS} = 5.0V for Logic Level and 3V Drive Devices

Fig 15. Peak Diode Recovery dv/dt Test Circuit for P-Channel HEXFET® Power MOSFETs



D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y M	DIMENSIONS				
В	MILLIMETERS INCHES				O T E S
O L	MIN.	MAX.	MIN.	MAX.	S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245	_	4
е	2.54	BSC	.100	.100 BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	_	.066	4
L2	_	1.78	_	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4.- CATHODE
3.- ANODE

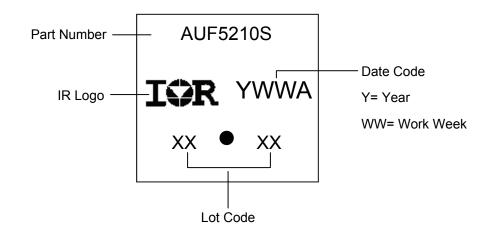
HEXFET

IGBTs, CoPACK

1.- GATE 2, 4.- DRAIN 3.- SOURCE

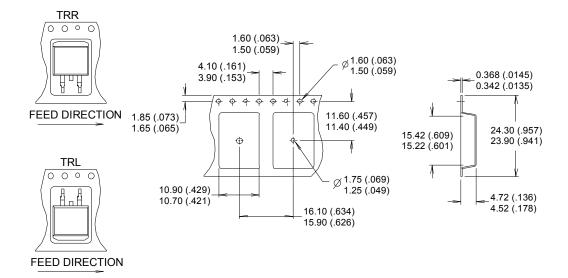
2, 4.- COLLECTOR 3.- EMITTER

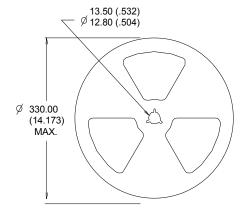
D²Pak (TO-263AB) Part Marking Information





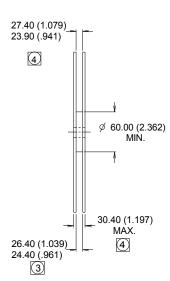
D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







- COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3
- DIMENSION MEASURED @ HUB.
 INCLUDES FLANGE DISTORTION @ OUTER EDGE.





Qualification Information

		Automotive				
		(per AEC-Q101)				
Qualification Level Comments: This part number(s) passed Automotive qualification Industrial and Consumer qualification level is granted by extension of Automotive level.						
Moisture Sensitivity Level D ² -Pak MSL1						
		Class M4 (+/-425V) [†]				
Machine Model		AEC-Q101-002				
Lluman Dadu Madal	Class H2 (/-4000V) [†]					
Human Body Model	AEC-Q101-001					
Charged Device Model		Class C5 (/-1125V) [†]				
		AEC-Q101-005				
RoHS Compliant Yes		Yes				
	Machine Model Human Body Model Charged Device Model	Industrial and C Automotive level Pensitivity Level Machine Model Human Body Model Charged Device Model				

[†] Highest passing voltage.

Revision History

Date	Comments		
0/30/2015	Updated datasheet with corporate template		
9/30/2015	Corrected ordering table on page 1.		

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